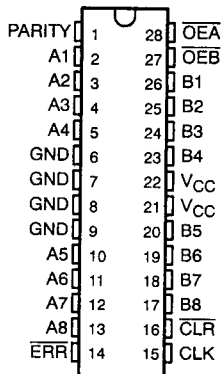


54ACT11833, 74ACT11833 8-BIT TO 9-BIT PARITY BUS TRANSCEIVERS

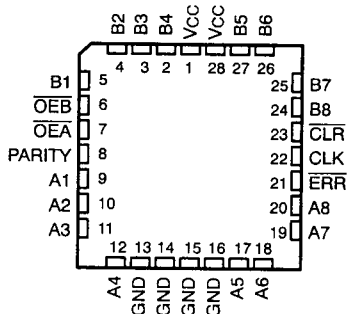
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- Inputs are TTL-Voltage Compatible
- High-Speed Bus Transceivers With Parity Generator/Checker
- Parity-Error-Flag Open-Drain Output
- Register for Storage of the Parity-Error Flag
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- EPIC™ (Enhanced-Performance Implanted CMOS) 1- μ m Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic “Small Outline” Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

54ACT11833 . . . JT PACKAGE
74ACT11833 . . . DW OR NT PACKAGE
(TOP VIEW)



54ACT11833 . . . FK PACKAGE
(TOP VIEW)



description

The 'ACT11833 is an 8-bit to 9-bit parity transceiver designed for two-way communication between data buses. When data is transmitted from the A bus to the B bus, a parity bit is generated. When data is transmitted from the B bus to the A bus with its corresponding parity bit, the ERR output will indicate whether or not an error in the B data has occurred. The output enable inputs OEA and OEB can be used to disable the device so that the buses are effectively isolated.

A 9-bit parity generator/checker generates a parity-odd output (PARITY) and monitors the parity of the I/O ports with an open-drain parity error flag (ERR). ERR is clocked into the register on the rising edge of the CLK input. The error flag register is cleared with a low pulse on the CLR input. When both OEA and OEB are low, data is transferred from the A bus to the B bus and inverted parity is generated. Inverted parity is a forced error condition that gives the designer more system diagnostic capability.

The 54ACT11833 is characterized for operation over the full military temperature range of -55°C to 125°C . The 74ACT11833 is characterized for operation from -40°C to 85°C .

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54ACT11833, 74ACT11833 8-BIT TO 9-BIT PARITY BUS TRANSCEIVERS

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Function Table

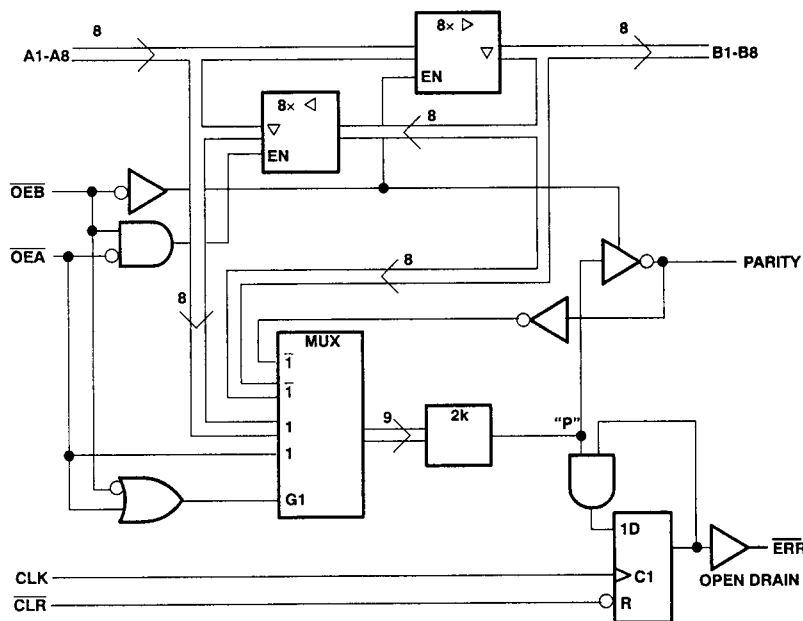
INPUTS						OUTPUT AND I/O				FUNCTION
$\overline{\text{OEB}}$	$\overline{\text{OEA}}$	$\overline{\text{CLR}}$	CLK	A \uparrow Σ of H's	B \uparrow Σ of H's	A	B	PARITY	$\overline{\text{ERR}}$	
L	H	X	X	Odd Even	NA	NA	A	L H	NA	A data to B bus and Generate Parity
H	L	H	\uparrow	NA	Odd Even	B	NA	NA	H L	B Data to A Bus and Check Parity
X	X	L	X	X	X	X	NA	NA	H	Clear Error Flag Register
H	H	H L H H	No \uparrow No \uparrow \uparrow \uparrow	X X Odd Even	X	Z	Z	Z	NC H H L	Isolation \ddagger
L	L	X	X	Odd Even	NA	NA	A	H L	NA	A Data to B Bus and Generate Inverted Parity

NA = Not applicable, NC = No change, X = Don't care

\uparrow Summation of high-level inputs includes PARITY along with Bi inputs.

\ddagger In this mode, the ERR output, when clocked, shows inverted parity of the A bus.

logic diagram (positive logic)



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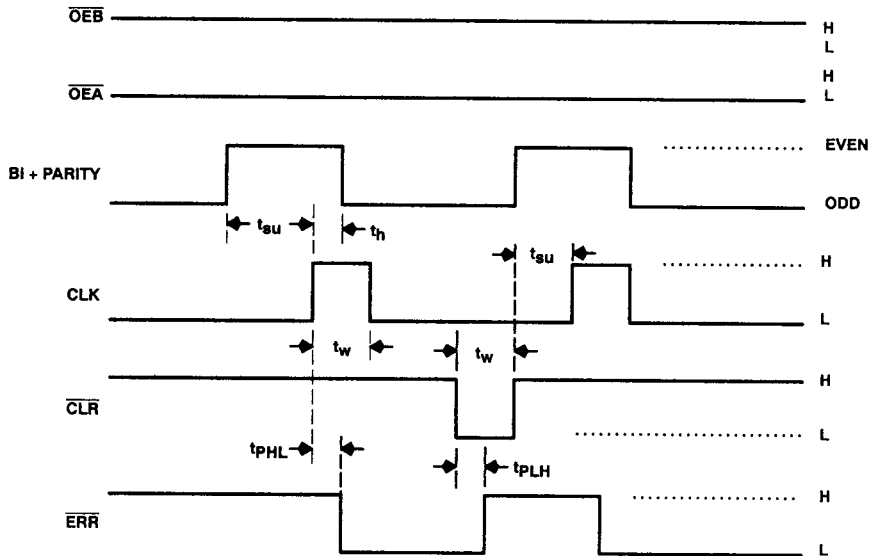
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Error-Flag Function Table

INPUTS		INTERNAL TO DEVICE	OUTPUT PRE-STATE	OUTPUT	FUNCTION
CLR	CLK	POINT "P"	ERR n-1	ERR	
H	↑	H	H	H	Sample
H	↑	X	L	L	
H	↑	L	X	L	
L	X	X	X	H	Clear

ERR n-1 represents the state of the ERR output before any changes at CLR, CLK, or point "P".

error-flag waveforms



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54ACT11833, 74ACT11833 8-BIT TO 9-BIT PARITY BUS TRANSCEIVERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	- 0.5 V to 7 V
Input voltage range, V_I (see Note 1)	- 0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	- 0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	± 20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	± 50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	± 50 mA
Continuous current through V_{CC} or GND pins	± 225 mA
Storage temperature range	- 65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions

	54ACT11833			74ACT11833			UNIT
	MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC} Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH} High-level input voltage	2			2			V
V_{IL} Low-level input voltage			0.8			0.8	V
V_I Input voltage	0		V_{CC}	0		V_{CC}	V
V_O Output voltage	0		V_{CC}	0		V_{CC}	V
I_{OH} High-level output current			- 24			- 24	mA
I_{OL} Low-level output current			24			24	mA
$\Delta t/\Delta v$ Input transition rise or fall rate	0		10	0		10	ns/V
T_A Operating free-air temperature	- 55		125	- 40		85	°C

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	T _A = 25°C			54ACT11833		74ACT11833		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	All outputs except ERR	I _{OH} = -50 μA	4.5 V	4.4			4.4	4.4	V		
			5.5 V	5.4			5.4	5.4			
		I _{OH} = -24 mA	4.5 V	3.94			3.7	3.8			
			5.5 V	4.94			4.7	4.8			
		I _{OH} = -50 mA [†]	5.5 V				3.85				
I _{OH} = -75 mA [†]	5.5 V					3.85					
V _{OL}		I _{OL} = 50 μA	4.5 V		0.1		0.1	0.1	V		
			5.5 V		0.1		0.1	0.1			
		I _{OL} = 24 mA	4.5 V		0.36		0.5	0.44			
			5.5 V		0.36		0.5	0.44			
		I _{OL} = 50 mA [†]	5.5 V				1.65				
I _{OL} = 75 mA [†]	5.5 V					1.65					
I _I	OE _A , OE _B , CLK, and CLR	V _I = V _{CC} or GND	5.5 V		± 0.1		± 1	± 1	μA		
I _{OZ}	A or B ports, PARITY [‡]	V _O = V _{CC} or GND	5.5 V		± 0.5		± 10	± 5	μA		
I _{CC}		V _I = V _{CC} or GND, I _O = 0	5.5 V		8		160	80	μA		
ΔI _{CC} [§]		One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V		0.9		1	1	mA		
C _i	OE _A , OE _B , CLK, and CLR	V _I = V _{CC} or GND	5 V		4.5				pF		
C _{io}	A or B ports, PARITY	V _O = V _{CC} or GND	5 V		12						

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

[‡] For I/O ports, the parameter I_{OZ} includes the input leakage current.

[§] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V to V_{CC}.

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted) (see Note 2)

			T _A = 25°C		54ACT11833		74ACT11833		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
t _w	Pulse duration	CLK high	5		5		5	ns	
		CLK low	5		5		5		
		CLR low	5		5		5		
t _{su}	Setup time before CLK [†]	Bi and PARITY	14		14		14	ns	
		CLR inactive	2		2		2		
t _h	Hold time after CLK [†] , Bi and PARITY		0		0		0	ns	

NOTE 2: Load circuit and voltage waveforms are shown in Section 1.

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TYP	UNIT
C _{pd}	Power dissipation capacitance per transceiver	Outputs enabled	A to B	87	pF
			B to A	60	
	Outputs disabled	A to B	28	pF	
		B to A	8		

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